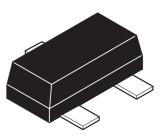


ZXTP19100CFF 100V, SOT23F, PNP medium power transistor

Summary

BV_{CEO} > -100V BV_{ECO} > -7V I_{C(cont)} = -2A V_{CE(sat)} < 120mV @ 1A R_{CE(sat)} = 95mΩ P_D = 1.5W



Description

Packaged in the SOT23 outline this new low saturation 100V PNP transistor offers extremely low on state losses making it ideal for use in DC-DC circuits and various driving and power management functions.

Features

• 2 amps continuous current

Complementary part number: ZXTN19100CFF

Very low saturation voltages

Applications

- Emergency lighting circuits
- Motor driving (including DC fans)
- · Solenoid, relay and actuator drivers
- DC-DC modules
- Backlight inverters
- Power switches
- MOSFET gate drivers

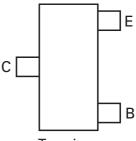
Ordering information

DEVICE	Reel size	Tape width	Quantity
	(inches)	(mm)	per reel
ZXTP19100CFFTA	7	8	3000

Device marking

1E1

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Top view

Absolute maximum ratings

Parameter	Symbol	Limit	Unit
Collector-base voltage	V _{CBO}	-110	V
Collector-emitter voltage (forward blocking)	V _{CEX}	-110	V
Collector-emitter voltage	V _{CEO}	-100	V
Emitter-collector voltage (reverse blocking)	V _{ECO}	-7	V
Emitter-base voltage	V _{EBO}	-7	V
Continuous collector current ^(c)	۱ _C	-2	А
Peak pulse current	I _{CM}	-3	А
Base current	۱ _B	-1	А
Power dissipation at T _A =25°C ^(a) Linear derating factor	P _D	0.84	W mW/°C
Power dissipation at T _A =25°C ^(b) Linear derating factor	P _D	1.34	W mW/°C
Power dissipation at T _A =25°C ^(c) Linear derating factor	PD	1.5	W mW/°C
Power dissipation at T _A =25°C ^(d) Linear derating factor	PD	2	W mW/°C
Operating and storage temperature range	T _j , T _{stg}	-55 to 150	°C

Thermal resistance

Parameter	Symbol	Value	Unit
Junction to Ambient ^(a)	$R_{\theta JA}$	149.3	°C/W
Junction to Ambient ^(b)	R _{θJA}	93.4	°C/W
Junction to Ambient ^(c)	R _{0JA}	83.3	°C/W
Junction to Ambient ^(d)	$R_{ hetaJA}$	60	°C/W
Junction to Case ^(e)	$R_{ ext{ heta}JC}$	38	°C/W

NOTES:

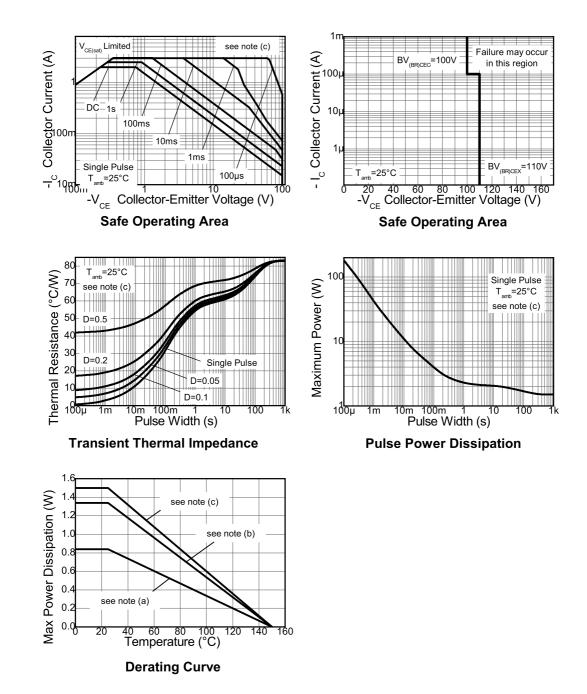
(a) For a device surface mounted on 15mm x 15mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.

(b) Mounted on 25mm x 25mm x 1.6mm FR4 PCB with a high coverage of single sided 2 oz copper in still air conditions. (c) Mounted on 50mm x 50mm x 1.6mm FR4 PCB with a high coverage of single sided 2 oz copper in still air conditions.

(d) As (c) above measured at t<5secs

(e) Junction to Case from Collector Tab.

Thermal characteristics



	Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
$\begin{array}{ c c c c c c c c c c c c c c c c c c c$		BV _{CBO}	-110	-135		V	I _C = -100μA
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Breakdown Voltage (Base	BV _{CEX}	-110	-135		V	0 1 20
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Breakdown Voltage (Base	BV _{CEO}	-100	-135		V	I _C = -10mA ^(*)
$\begin{array}{ c c c c c c c c c c c c c c c c c c c$		BV _{EBO}	-7	-8.3		V	I _E = -100μA
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Breakdown Voltage	BV _{ECX}	-7	-8.3		V	_
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Breakdown Voltage (Base	BV _{ECO}	-7	-8.7		V	I _E = -100μA
$\begin{array}{c c c c c c c c c c c c c c c c c c c $		I _{CBO}		<-1			
Saturation Voltage -95 -120 -120 mV mV $I_{C} = -1A, I_{B} = -100mA(*)$ $I_{C} = -1A, I_{B} = -50mA(*)$ $I_{C} = -1A, I_{B} = -50mA(*)$ Base-Emitter Saturation Voltage $V_{BE(sat)}$ -870 -950 mV $I_{C} = -2A, I_{B} = -200mA(*)$ Base-Emitter Turn-On Voltage $V_{BE(on)}$ -870 -950 mV $I_{C} = -2A, I_{B} = -200mA(*)$ Base-Emitter Turn-On Voltage $V_{BE(on)}$ -810 -900 mV $I_{C} = -2A, V_{CE} = -2V(*)$ Static Forward Current Transfer Ratio h_{FE} 200330500 $I_{C} = -100mA, V_{CE} = -2V(*)$ Iransition Frequency f_{T} 142MHz $I_{C} = -100mA, V_{CE} = -2V(*)$ Input Capacitance C_{ibo} 291400pF $V_{EB} = -0.5V, f = 1MHz(*)$ Output Capacitance C_{obo} 23.5pF $V_{CB} = -10V, f = 10MHz(*)$ Delay Time t_{d} 24.7ns $I_{C} = -500mA, V_{CC} = -10V$ Rise Time t_{r} 22.4ns $I_{C} = -500mA, V_{CC} = -10V$ Istorage Time t_{s} 660ns $I_{C} = -500mA, V_{CC} = -10V$		I _{EBO}		<-1	-50	nA	V _{EB} = -5.6V
$\begin{array}{c c c c c c c c c c c c c c c c c c c $		V _{CE(sat)}		-100	-130	mV	$I_{C} = -0.5A, I_{B} = -20mA^{(*)}$
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Saturation Voltage			-95	-120	mV	$I_{C} = -1A$, $I_{B} = -100 \text{mA}^{(*)}$
$\begin{array}{c c c c c c c c c c c c c c c c c c c $				-175	-225	mV	с <u>р</u>
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $				-215	-275	mV	$I_{C} = -2A, I_{B} = -200 \text{mA}^{(*)}$
Voltage Delonit Fe 200 330 500 $I_C = -100 \text{mA}, V_{CE} = -2V^{(*)}$ Static Forward Current Transfer Ratio h_{FE} 200 330 500 $I_C = -100 \text{mA}, V_{CE} = -2V^{(*)}$ Transition Frequency f_T 135 20 30 MHz $I_C = -100 \text{mA}, V_{CE} = -2V^{(*)}$ Input Capacitance f_T 142 MHz $I_C = -100 \text{mA}, V_{CE} = -10V$ $f = 50 \text{MHz}$ Input Capacitance C_{ibo} 291 400 pF $V_{EB} = -0.5V, f = 1 \text{MHz}^{(*)}$ Output Capacitance C_{obo} 23.5 pF $V_{CB} = -10V, f = 1 \text{MHz}^{(*)}$ Delay Time t_d 24.7 ns $I_C = -500 \text{mA}, V_{CC} = -10V$ Rise Time t_r 22.4 ns $I_C = -500 \text{mA}, V_{CC} = -10V$ $Storage Time$ t_s 660 ns $I_L = -I_{B2} = -50 \text{mA}$		V _{BE(sat)}		-870	-950	mV	I _C = -2A, I _B = -200mA ^(*)
Transfer RatioTCTO135 20ICICION IN (TCEICTransition Frequency f_T 135 2030ICICICICICTransition Frequency f_T 142MHzICICICICICICInput CapacitanceCC291400pFVEBICIMHzICIMHzICIMHzOutput CapacitanceCC23.5pFVCBIMHzImHzIm		V _{BE(on)}		-810	-900	mV	$I_{\rm C}$ = -2A, $V_{\rm CE}$ = -2V ^(*)
70 135 $1_{C} = -1A, V_{CE} = -2V^{1/2}$ 20 30 $1_{C} = -2A, V_{CE} = -2V^{(*)}$ $I_{C} = -2A, V_{CE} = -2V^{(*)}$ $I_{C} = -2A, V_{CE} = -2V^{(*)}$ Transition Frequency f_{T} 142 MHz $I_{C} = -100mA, V_{CE} = -10V$ Input Capacitance C_{ibo} 291 400 pF $V_{EB} = -0.5V, f = 1MHz^{(*)}$ Output Capacitance C_{obo} 23.5 pF $V_{CB} = -10V, f = 1MHz^{(*)}$ Delay Time t_d 24.7 ns $I_{C} = -500mA, V_{CC} = -10V$ Rise Time t_r 22.4 ns $I_{C} = -500mA, V_{CC} = -10V$ Storage Time t_s 660 ns $I_{B1} = -I_{B2} = -50mA$		h _{FE}	200	330	500		$I_{C} = -100 \text{mA}, V_{CE} = -2V^{(*)}$
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Transfer Ratio		70	135			
$ \begin{array}{ c c c c c c c } \hline \end{tabular} & t$			20	30			$I_{C} = -2A, V_{CE} = -2V^{(*)}$
	Transition Frequency	f _T		142		MHz	
	Input Capacitance	C _{ibo}		291	400	pF	V _{EB} = -0.5V, f = 1MHz ^(*)
$\begin{tabular}{c c c c c c c c c c c c c c c c c c c $	Output Capacitance			23.5		pF	
Rise Time t_r 22.4ns $I_C = -500$ mA, $V_{CC} = -10V$ Storage Time t_s 660ns	Delay Time			24.7		ns	
Storage Time t_s 660 ns $I_{B1} = -I_{B2} = -50 \text{mA}$	Rise Time			22.4		ns	
	Storage Time			660		ns	$I_{B1} = -I_{B2} = -50 \text{mA}$
	Fall Time			107		ns	

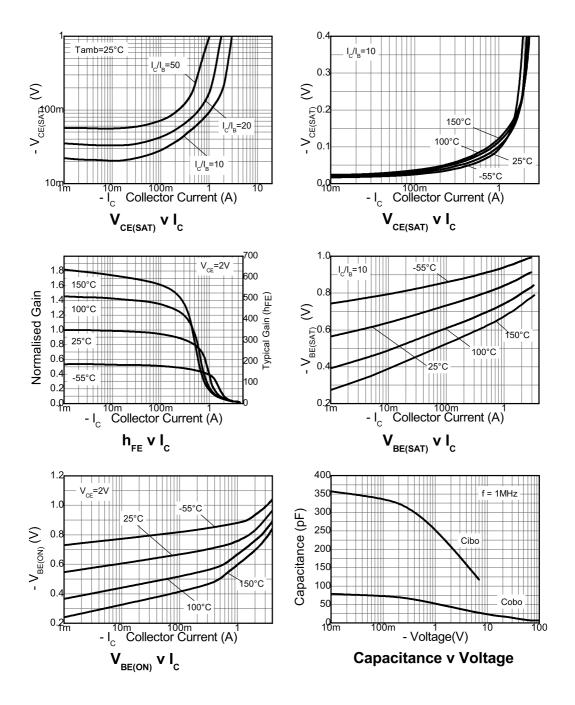
Electrical characteristics (at $T_{amb} = 25^{\circ}C$ unless otherwise stated).

NOTES:

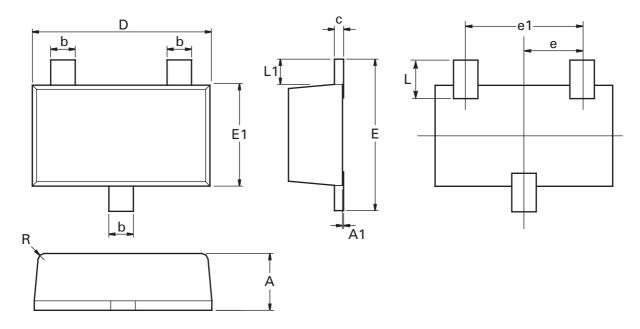
(*) Measured under pulsed conditions. Pulse width $\leq 300 \mu s;$ duty cycle $\leq 2\%.$

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Typical characteristics



Package outline - SOT23F



Dim.	Millimeters		Inches		Dim.	Dim. Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.80	1.00	0.0315	0.0394	E	2.30	2.50	0.0906	0.0984
A1	0.00	0.10	0.00	0.0043	E1	1.50	1.70	0.0590	0.0669
b	0.35	0.45	0.0153	0.0161	L	0.48	0.68	0.0189	0.0268
С	0.10	0.20	0.0043	0.0079	L1	0.30	0.50	0.0153	0.0161
D	2.80	3.00	0.1102	0.1181	R	0.05	0.15	0.0019	0.0059
е	0.95	ref	0.037	74 ref	0	0°	12°	0°	12°
e1	1.80	2.00	0.0709	0.0787	-	-	-	-	-

Note: Controlling dimensions are in millimeters. Approximate dimensions are provided in inches

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"Obsolete"	Production has been discontinued
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